## Application/Control No. Applicant(s)/Patent Under Reexamination 09/910,329 PAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2662 Hanh Nguyen **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,594,720	01-1997	Papadopoulos et al.	370/330
	٠в	US-6,714,523 B2	03-2004	Zeira et al.	370/320
	Ċ	US-6,791,961	09-2004	Zeira et al.	370/335
	D	US-6,144,652	11-2000	Avidor et al.	370/336
	Ε	US-			
	F	US-			
	G	US-		,	
	Н	US-			
	, I	US-			
	J	US-			
	К	US			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			-		
	0				,	
	Р					
	Q					
	R					4
	s					
	Т		·			

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.